





Issue Classification 	Application/Control No. 10/672,774	Applicant(s)/Patent under Reexamination CHEN ET AL.
	Examiner Ryan P. Fiegle	Art Unit 2183

ISSUE CLASSIFICATION												
ORIGINAL					INTERNATIONAL CLASSIFICATION							
CLASS		SUBCLASS			CLAIMED					NON-CLAIMED		
712		218			g	6	f	9	/30			/
CROSS REFERENCES									/			/
CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)								/			/
712	217								/			/
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 4/14/06 (Assistant Examiner) (Date)					 EDDIE CHAN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100 (Primary Examiner) (Date) 4/14/06					Total Claims Allowed: 58		
 4-17-06 (Legal Instruments Examiner) (Date)										O.G. Print Claim(s)		O.G. Print Fig. 1

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
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